$V_{DRM} = 4500 V$ 

 $I_{TGQM} = 2000 A$ 

= 13 kA I<sub>TSM</sub>

 $V_{T0}$ = 1.80 V

r<sub>T</sub> = 0.85 m $\Omega$  $V_{DClin} = 2200 V$ 

5SGA 20H4502

**Gate turn-off Thyristor** 

Doc. No. 5SYA 1210-01 Aug. 2000

- Patented free-floating silicon technology
- Low on-state and switching losses
- · Annular gate electrode
- Industry standard housing
- Cosmic radiation withstand rating

## **Blocking**

$V_{DRM}$	Repetitive peak off-state voltage		4500	V	$V_{GR} \ge 2V$		
$V_{RRM}$	Repetitive peak reverse voltage		17	V			
I <sub>DRM</sub>	Repetitive peak off-state current	<b>\leq</b>	100	mΑ	$V_D = V_{DRM}$ $V_{GR} \ge 2V$		
I <sub>RRM</sub>	Repetitive peak reverse current	<b>\leq</b>	50	mΑ	$V_R = V_{RRM}$ $R_{GK} = \infty$		
$V_{DClink}$	Permanent DC voltage for 100		2200	V	$-40 \le T_j \le 125$ °C. Ambient cosmic		
	FIT failure rate				radiation at sea level in open air.		

#### Mechanical data (see Fig. 19)

	moonamoar data (666 i ig. 16)					
F <sub>m</sub>	Mounting force	min.		17	kN	
	Mounting force	max.		24	kN	
Α	Acceleration:					
	Device unclamped			50	m/s <sup>2</sup>	
	Device clamped			200	m/s <sup>2</sup>	
М	Weight			0.8	kg	
Ds	Surface creepage distance		2	22	mm	
Da	Air strike distance		2	13	mm	



# **GTO Data**

# On-state

I <sub>TAVM</sub>	Max. average on-state current	710 A	Half sine wave, $T_C = 85  ^{\circ}C$			
I <sub>TRMS</sub>	Max. RMS on-state current	1115 A				
I <sub>TSM</sub>	Max. peak non-repetitive	13 kA	$t_P = 10 \text{ ms}  T_j = 125^{\circ}\text{C}$			
	surge current	24 kA	t <sub>P</sub> = 1 ms After surge:			
I <sup>2</sup> t	Limiting load integral	0.85·10 <sup>6</sup> A <sup>2</sup> s	$t_P = 10 \text{ ms}$ $V_D = V_R = 0V$			
		0.29·10 <sup>6</sup> A <sup>2</sup> s	t <sub>P</sub> = 1 ms			
V <sub>T</sub>	On-state voltage	3.50 V	I <sub>T</sub> = 2000 A			
V <sub>T0</sub>	Threshold voltage	1.80 V	$I_T = 400 - 3000 \text{ A}$ $T_j = 125 ^{\circ}\text{C}$			
r <sub>T</sub>	Slope resistance	0.85 mΩ				
I <sub>H</sub>	Holding current	50 A	T <sub>j</sub> = 25 °C			

## Gate

$V_{GT}$	Gate trigger voltage	1.0 V	$V_D = 24 \text{ V}$ $T_j = 25 \text{ °C}$
I <sub>GT</sub>	Gate trigger current	2.5 A	$R_A = 0.1 \Omega$
$V_{GRM}$	Repetitive peak reverse voltage	17 V	
I <sub>GRM</sub>	Repetitive peak reverse current	50 mA	$V_{GR} = V_{GRM}$

**Turn-on switching** 

	arr on switching						
di/dt <sub>crit</sub>	Max. rate of rise of on-state	400 A/µs	f = 200Hz	$I_T = 2000$	) A,	$T_j =$	125 °C
	current	600 A/µs	f = 1Hz	$I_{GM} = 30$	A, di <sub>G</sub>	;/dt =	= 20 A/µs
t <sub>d</sub>	Delay time	2.0 µs	V <sub>D</sub> =	0.5 V <sub>DRM</sub>	Tj	=	125 °C
t <sub>r</sub>	Rise time	6.0 µs	I <sub>T</sub> = 20	000 A	di/dt	=	200 A/µs
t <sub>on(min)</sub>	Min. on-time	80 µs	I <sub>GM</sub> =	30 A	di <sub>G</sub> /dt	=	20 A/µs
E <sub>on</sub>	Turn-on energy per pulse	2.50 Ws	C <sub>S</sub> =	4 µF	$R_s$	=	5 Ω

**Turn-off switching** 

	i Swittering		
$I_{TGQM}$	Max controllable turn-off	2000 A	$V_{DM} = V_{DRM}$ $di_{GQ}/dt = 30 A/\mu s$
	current		$C_S$ = 4 $\mu F$ $L_S$ $\leq$ 0.3 $\mu H$
t <sub>s</sub>	Storage time	22.0 µs	$V_D = \frac{1}{2} V_{DRM}  V_{DM} = V_{DRM}$
t <sub>f</sub>	Fall time	3.0 µs	$T_j = 125  ^{\circ}C  di_{GQ}/dt = 30  A/\mu s$
t <sub>off(min)</sub>	Min. off-time	80 µs	$I_{TGQ} = I_{TGQM}$
E <sub>off</sub>	Turn-off energy per pulse	7.5 Ws	$C_S = 4 \mu F R_S = 5 \Omega$
$I_{\text{GQM}}$	Peak turn-off gate current	725 A	L <sub>S</sub> ≤ 0.3 µH

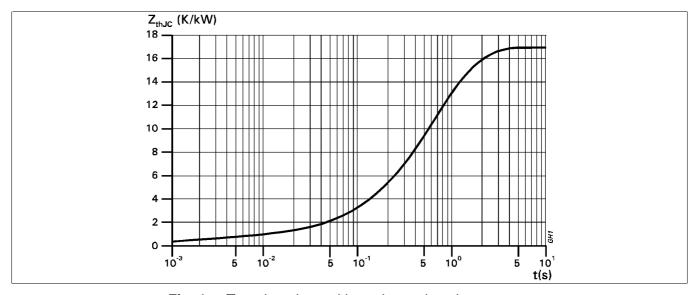
### **Thermal**

T <sub>j</sub>	Storage and operating	-40125°C	
	junction temperature range		
R <sub>thJC</sub>	Thermal resistance	30 K/kW	Anode side cooled
	junction to case	39 K/kW	Cathode side cooled
		17 K/kW	Double side cooled
R <sub>thCH</sub>	Thermal resistance case to	10 K/kW	Single side cooled
	heat sink	5 K/kW	Double side cooled

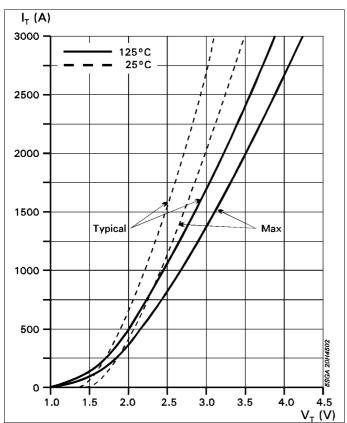
# Analytical function for transient thermal impedance:

$$Z_{thJC}(t) = \sum_{i=1}^{4} R_i(1 - e^{-t/\tau_i})$$

i	1	2	3	4
R <sub>I</sub> (K/kW)	11.7	4.7	0.64	0.0001
τ <sub>i</sub> (s)	0.9	0.26	0.002	0.001



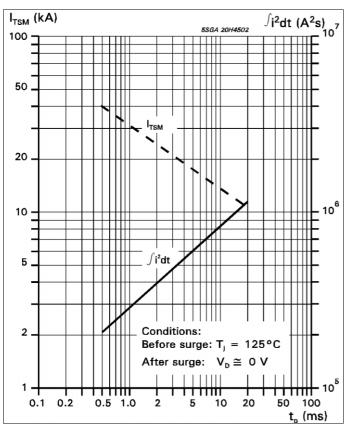
**Fig. 1** Transient thermal impedance, junction to case.



P<sub>AV</sub> (kW) 3.5 3.0 2.5 -DC 180° Л 180° sine 120° □ 2.0 60° ∏ 1.5 1.0 0.5 5SGA 20H4502 200 400 600 800 1000 1200 0  $I_{TAV}$  (A)

Fig. 2 On-state characteristics

**Fig. 3** Average on-state power dissipation vs. average on-state current.



**Fig. 4** Surge current and fusing integral vs. pulse width

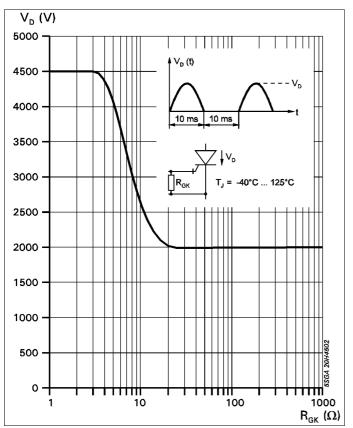


Fig. 5 Forward blocking voltage vs. gate-cathode resistance.

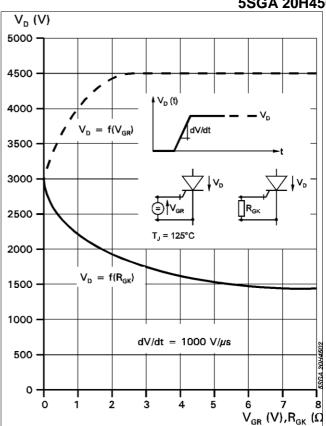
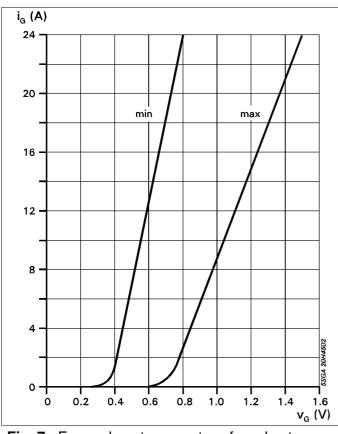
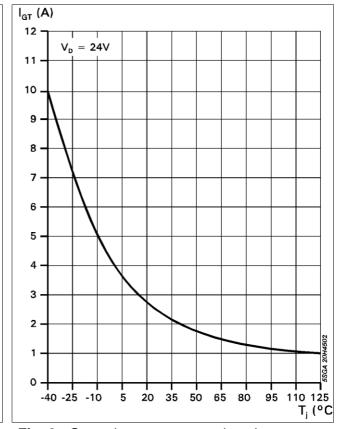


Fig. 6 Static dv/dt capability: Forward blocking voltage vs. neg. gate voltage or gate cathode resistance.



Forwarde gate current vs. forard gate Fig. 7 voltage.



Gate trigger current vs. junction Fig. 8 temperature

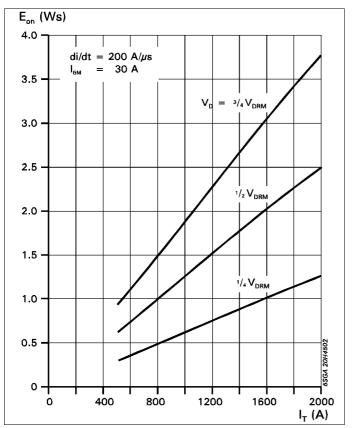
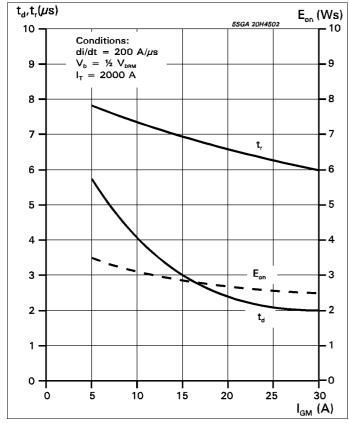
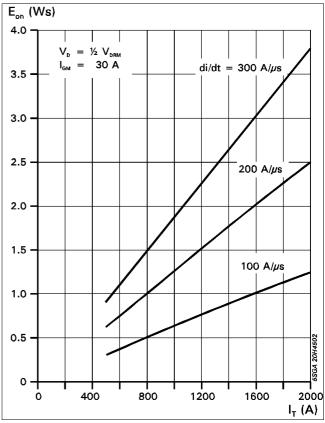


Fig. 9 Turn-on energy per pulse vs. on-state current and turn-on voltage.



**Fig. 11** Turn-on energy per pulse vs. on-state current and turn-on voltage.



**Fig. 10** Turn-on energy per pulse vs. on.-state current and current rise rate

Common Test conditions for figures 9, 10 and 11:

$$di_G/dt = 20 \text{ A/}\mu\text{s}$$
 $C_S = 4 \mu\text{F}$ 
 $R_S = 5 \Omega$ 
 $Tj = 125 ^{\circ}\text{C}$ 

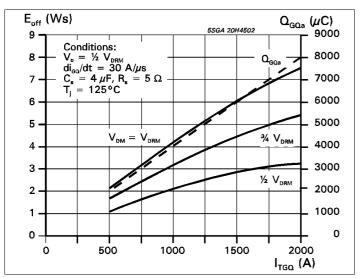
Definition of Turn-on energy:

$$E_{OR} = \int_{0}^{20 \,\mu s} V_D \cdot I \tau dt \quad (t = 0, I_G = 0.1 \cdot I_{GM})$$

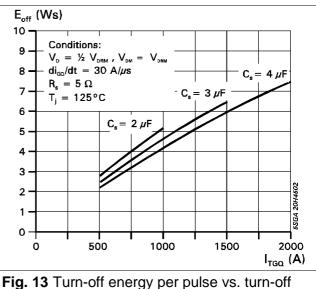
Common Test conditions for figures 12, 13 and 15:

Definition of Turn-off energy:

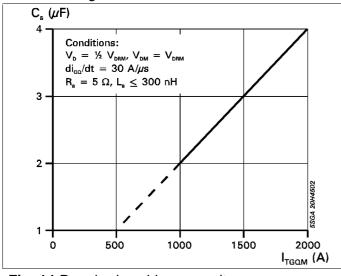
$$E_{off} = \int_{0}^{40 \,\mu s} V_D \cdot I_T dt \quad (t = 0, I_T = 0.9 \cdot I_{TGQ})$$



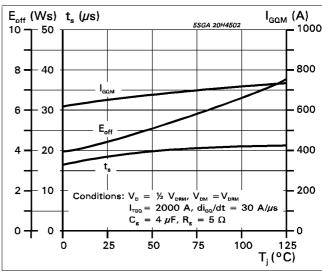
**Fig. 12** Turn-off energy per pulse vs. turn-off current and peak turn-off voltage. Extracted gate charge vs. turn-off current.



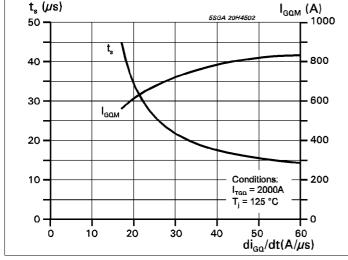
**Fig. 13** Turn-off energy per pulse vs. turn-of current and snubber capacitance.



**Fig. 14** Required snubber capacitor vs. max allowable turn-off current.



**Fig. 15** Turn-off energy per pulse, storage time and peak turn-off gate current vs. junction temperature



**Fig. 16** Storage time and peak turn-off gate current vs. neg. gate current rise rate.

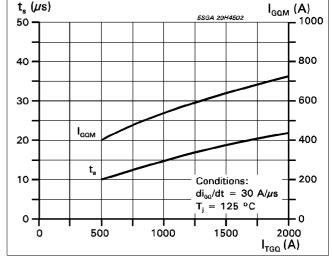


Fig. 17 Storage time and peak turn-off gate current vs. turn-off current

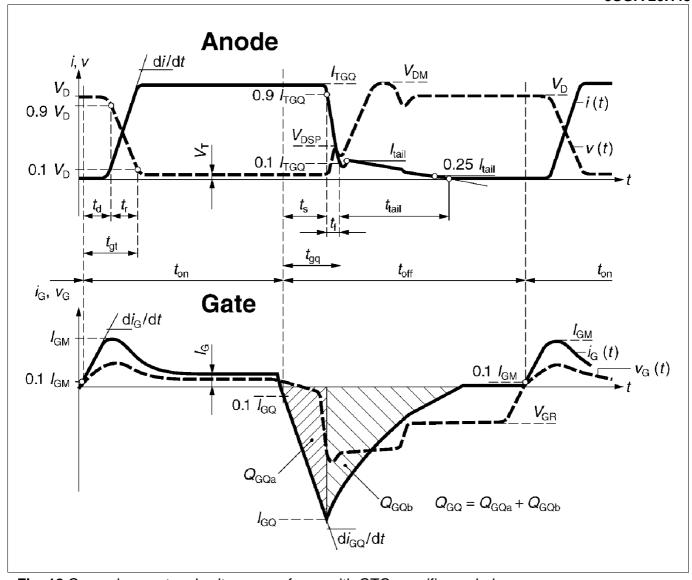
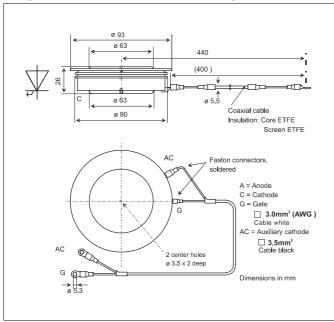


Fig. 18 General current and voltage waveforms with GTO-specific symbols



**Fig. 19** Outline drawing. All dimensions are in millimeters and represent nominal values unless stated otherwise.

## Reverse avalanche capability

In operation with an antiparallel freewheeling diode, the GTO reverse voltage  $V_R$  may exceed the rate value  $V_{RRM}$  due to stray inductance and diode turn-on voltage spike at high di/dt. The GTO is then driven into reverse avalanche. This condition is not dangerous for the GTO provided avalanche time and current are below 10  $\mu$ s and 1000 A respectively. However, gate voltage must remain negative during this time. Recommendation :  $V_{GR} = 10...$  15 V.

ABB Semiconductors AG reserves the right to change specifications without notice.



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